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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/676,707	09/30/2003	May Tom-Moy	10031347-1	8124

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AGILENT TECHNOLOGIES, INC.
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EXAMINER

LUM, LEON YUN BON

ART UNIT	PAPER NUMBER
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1641

DATE MAILED: 10/23/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary	Application No. 10/676,707	Applicant(s) TOM-MOY ET AL.	
	Examiner Leon Y. Lum	Art Unit 1641	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 03 August 2006.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-15 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-15 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|---|---|
| 1) <input type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application |
| 3) <input checked="" type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)
Paper No(s)/Mail Date <u>8/3/06</u> | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on August 3, 2006 has been entered.

Claim Rejections - 35 USC § 103

2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

3. The factual inquiries set forth in *Graham v. John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

1. Determining the scope and contents of the prior art.
2. Ascertaining the differences between the prior art and the claims at issue.

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3. Resolving the level of ordinary skill in the pertinent art.
4. Considering objective evidence present in the application indicating obviousness or nonobviousness.

4. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

5. Claims 1-5, 7-8, 10-11, and 13-14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Park et al (Science, 2002) in light of Fluke Corporation (Fluke Model 187 & 189 True RMS Multimeter Users Manual, 2000), and in view of Eggers et al (US 5,891,630).

Park et al reference teaches the electrical detection of DNA by detecting binding between a capture oligonucleotide strand located in the gap between two fixed microelectrodes and a longer target oligonucleotide in solution (i.e. contacting feature with sample; probe disposed between first and second electrodes; polynucleotide). See page 1503, middle column, 2nd paragraph to right column, 1st paragraph. Park et al also teach an array of 4 electrode pairs with a different oligonucleotide capture strand in the electrode gap (i.e. microarray with a plurality of features; plurality of targets are

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detected), wherein the oligonucleotide strands are immobilized onto a layer of SMPB-modified SiO_2 coated onto a Si wafer (i.e. pad of resistive material disposed on the substrate; probe supported on pad of resistive material). See page 1503, right column, 3rd paragraph to page 1504, left column, 2nd paragraph. In addition, Park et al teach the step of increasing the sensitivity of the device by exposing the active component of the device to a solution of Ag(I) and hydroquinone (i.e. applying a source of metal ions). See page 1503, right column, 2nd paragraph. Park et al further teach capacitance or conductivity measurements to determine the number of target molecules that fill the gap (i.e. analyzing the results to detect the target). See page 1503, right column, 2nd paragraph. Furthermore, Park et al teach measuring the resistance value across the gaps with a Fluke 189 multimeter (i.e. select one of the plurality of features to be interrogated; measuring the observable property at the selected feature). See page 1504, left column, 3rd paragraph to middle column, 1st paragraph. Since the Fluke 189 multimeter can only perform one measurement at a time, the detection of the 4-electrode pair array necessarily requires sequential detection, which indicates that the electrode pairs are selectively interrogated (i.e. repeating steps (c) and (d) to selectively interrogate each of the plurality of features). See Fluke Corporation, pages 2-4, 2-17, 3-6, and 3-7.

However, Park et al fail to teach that the substrate comprises integrated addressing circuitry in operable relation to each of the plurality of features and also fail to teach the step of providing a signal to the addressing circuitry to select one of the pluralities of features to be interrogated.

Eggers et al reference teaches detection circuitry 16 on-chip, wherein a varying signal of frequency can be applied to each site, in order to enable fast detection of hybridization for large DNA probe arrays. See column 4, lines 16-18; column 7, lines 30-32 and lines 44-46; and Figure 1.

It would have been obvious to one of ordinary skill in the art at the time of the invention to modify the method and apparatus of Park et al with detection circuitry 16 on-chip, as taught by Eggers et al, in order to enable fast detection of hybridization for large DNA probe arrays. The detection circuitry of Eggers et al therefore provides an advantage over the multimeter of Park et al since the detection circuitry is able to interrogate a large number of electrode pairs in a short amount of time, whereas the handheld multimeter of Park et al would require a large amount of time to test each electrode pair in a large array. In addition, one of ordinary skill in the art at the time of the invention would have had reasonable expectation of success in including the detection circuitry of Eggers et al, in the apparatus of Park et al, since Park et al teach dual electrodes to detect hybridization in an array, and the detection circuitry of Eggers et al is connected to a plurality of electrode pairs that also detect hybridization. With regards to claims 3-5, Park et al teach that the target oligonucleotide is attached to Au nanoparticles at one end (i.e. gold nanoparticle label) and that Ag(I) and hydroquinone is added after the binding of target and capture oligonucleotides (i.e. attaching a label to target prior to applying the enhancement reaction; deposits metal). See page 1503, right column, 1st paragraph; and Figure 1 and caption.

In regards to claim 11, Eggers et al teach circuitry for processing information related to target detection. See column 4, lines 31-33.

6. Claim 6 is rejected under 35 U.S.C. 103(a) as being unpatentable over Park et al (Science, 2002) in view of Eggers et al (US 5,891,630) as applied to claims 1 and 3 above, and further in view of Cheung (US 5,132,242).

Park et al and Eggers et al references have been disclosed above, but fail to teach that the label is attached to the target via a biotin-avidin conjugate binding pair.

Cheung reference teaches conjugation of DNA to microspheres using avidin and biotin, in order to take advantage of the strong non-covalent interaction between avidin and biotin. See column 10, lines 46-53.

It would have been obvious to one of ordinary skill in the art at the time of the invention to modify the method of Park et al and Eggers et al with conjugation of DNA to microspheres using avidin and biotin, as taught by Cheung, in order to take advantage of the strong non-covalent interaction between avidin and biotin. The avidin-biotin conjugation to connect DNA to microspheres, as taught by Cheung, provides an advantage over the oligonucleotide-modified particles of Park et al and Eggers et al, since the avidin-biotin conjugation provides a strong interaction that would not allow dissociation of the microspheres from the bound targets and result in false negatives. One of ordinary skill in the art at the time of the invention would have had reasonable expectation of success in including the avidin and biotin binding pairs, as taught by Cheung, in the method of Park et al and Eggers et al, since Park et al and Eggers et al

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teach particles bound to nucleic acids, and the avidin and biotin binding pairs of Cheung are able to conjugate microspheres, a type of particle, to nucleic acids.

7. Claim 9 is rejected under 35 U.S.C. 103(a) as being unpatentable over Park et al (Science, 2002) in view of Eggers et al (US 5,891,630) as applied to claim 8, and further in view of Nayak (US 4,789,628).

Park et al and Eggers et al references have been disclosed above, but fail to teach that the pad of resistive material comprises a plurality of segments with fissures between the segments.

Nayak reference teaches a plurality of spaced projections within a well with probes immobilized thereon, in order to increase the surface area for specific binding in assays that may have a low concentration of substances. See column 3, line 51 to column 4, line 10; and column 6, line 62 to column 7, line 19.

It would have been obvious to one of ordinary skill in the art at the time of the invention to modify the apparatus of Park et al and Eggers et al with a plurality of spaced projections within a well with probes immobilized thereon, as taught by Nayak, in order to increase the surface area for specific binding in assays that may have a low concentration of substances. By replacing the planar surface of Park et al and Eggers et al with the projections of Nayak, the apparatus of Park et al and Eggers et al would have the advantage of being able to detect specific binding with a sample solution having a low concentration of target. This advantage therefore provides the motivation to combine the projections of Nayak in the apparatus of Park et al and Eggers et al. In

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addition, one of ordinary skill in the art at the time of the invention would have had a reasonable expectation of success in including the projections of Nayak in the apparatus of Park et al and Eggers et al, since Park et al and Eggers et al teach probes immobilized on a surface for assay purposes, and the projections of Nayak are one example of a surface that can immobilize probes for an assay.

8. Claim 12 is rejected under 35 U.S.C. 103(a) as being unpatentable over Park et al (Science, 2002) in view of Eggers et al (US 5,891,630) as applied to claim 8, and further in view of Mallet et al (US 6,660,533 B2).

Park et al and Eggers et al references have been disclosed above, but fail to teach that the pad of resistive material is metal oxide.

Mallet et al reference teaches metal oxides surfaces, in order to provide an immobilization that engenders very good signal to background noise ratios, and stable immobilization. See column 2, lines 45-53.

It would have been obvious to one of ordinary skill in the art at the time of the invention to modify the apparatus of Park et al and Eggers et al with metal oxides surfaces, as taught by Mallet et al, in order to provide an immobilization that engenders very good signal to background noise ratios, and stable immobilization. By providing good signal to background noise ratios, the binding of Park et al and Eggers et al would be more accurately detected. In addition, one of ordinary skill in the art at the time of the invention would have had reasonable expectation of success in including the metal oxide surfaces of Mallet et al, in the apparatus of Park et al and Eggers et al,

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since Park et al and Eggers et al teach biomolecule immobilization onto surfaces, and the metal oxide of Mallet et al is one type of surface that can immobilize biomolecules.

9. Claim 15 is rejected under 35 U.S.C. 103(a) as being unpatentable over Park et al (Science, 2002) in view of Eggers et al (US 5,891,630) as applied to claim 8 as applied above, and further in view of Sandstrom (US 6,545,758 B1).

Park et al and Eggers et al reference has been disclosed above, but fail to teach at least one reference feature in operable relation to the addressing circuitry.

Sandstrom reference teaches control sites on a microarray, in order to compare experimental probe sites to a reference or purposefully mismatched site for eliminating signal from background signal and nonspecific hybridization. See column 4, line 61 to column 5, line 17.

It would have been obvious to one of ordinary skill in the art at the time of the invention to modify the apparatus of Park et al and Eggers et al with control sites on a microarray, as taught by Sandstrom, in order to compare experimental probe sites to a reference or purposefully mismatched site for eliminating signal from background signal and nonspecific hybridization. The control sites of Sandstrom therefore provide the advantage of determining accurate detection in the binding sites of Park et al and Eggers et al. In addition, one of ordinary skill in the art at the time of the invention would have had reasonable expectation of success in including control sites, as taught by Sandstrom, in the apparatus of Park et al and Eggers et al, since Park et al and

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Eggers et al teach an array of binding sites, and the control sites of Sandstrom can also be placed in an array of binding sites.

Response to Arguments

10. Applicants' amendment to independent claim 8 has overcome the previous applied reference. However, new grounds of rejections have been applied on the instant claim and all dependant claims thereof. Independent claim 1 and all dependant claims thereof remain rejected under the previously applied references for the following reasons:

Applicants argue in the Remarks section of the Response filed June 21, 2006 that the combined teachings of Parks and Eggers 2 do not disclose or suggest "a pad or resistive material on the substrate between the first and second electrodes." See pages 6-7. In addition, Applicants argue "for the reasons presented above with regard to Eggers 1 and claim 8, Eggers 2 does not cure the above deficiencies of the combined teachings of Park and Fluke." See top of page 7. This statement refers to Applicants' argument that Eggers 1 fails to disclose two distinct materials that would constitute the claimed "pad of resistive material on a substrate." See page 5, last paragraph spanning page 6, 1st paragraph.

It has been determined that Applicants' term "resistive" as supported in the specification applies to any material that is able to resist the flow of electricity, including silicon dioxide. See previous "Response to Arguments" section in the Office Action

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made Final, mailed March 17, 2006, pages 11-13. Applicants' arguments in the Remarks section of the instant Response do not address this response set forth by the Examiner, and it is respectfully presumed that Applicants do not rebut Examiner's arguments.

Since silicon dioxide is considered a "resistive" material by Applicants' standards, a teaching of a silicon dioxide layer placed on top of a substrate would satisfy the claimed requirement of two distinct materials that would constitute a "pad of resistive material on a substrate." As highlighted in the rejection supra, Park et al teach a silicone wafer (i.e. substrate) with a layer of modified silicon dioxide thereon (i.e. resistive material), to which a layer of capture oligonucleotides are immobilized. Therefore, since Park et al teach the required limitation of both a resistive material and a substrate, Applicants' arguments are not found to be convincing, and the previous rejections with respect to independent claim 1 and all dependent claims thereof are maintained.

Conclusion


11. No claims are allowed.

12. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Leon Y. Lum whose telephone number is (571) 272-2878. The examiner can normally be reached on weekdays from 8:00am-5:00pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Long Le can be reached on (571) 272-0823. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.



Leon Y. Lum
Patent Examiner
Art Unit 1641



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